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September 2016

# FDMC86260

# N-Channel Shielded Gate PowerTrench® MOSFET 150 V, 25 A, 34 m $\Omega$

# **Features**

- Shielded Gate MOSFET Technology
- Max  $r_{DS(on)} = 34 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 5.4 \text{ A}$
- Max  $r_{DS(on)}$  = 44 m $\Omega$  at  $V_{GS}$  = 6 V,  $I_D$  = 4.8 A
- High Performance Technology for Extremely Low r<sub>DS(on)</sub>
- 100% UIL Tested
- Termination is Lead-free
- RoHS Compliant

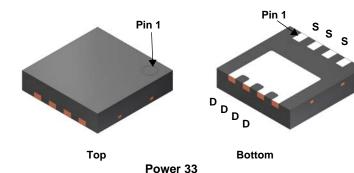


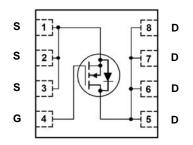
# **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

# **Application**

■ DC-DC Conversion





# **MOSFET Maximum Ratings** T<sub>A</sub> = 25 °C unless otherwise noted.

| Symbol                            |                   | Parameter               |                        |           |             | Units |
|-----------------------------------|-------------------|-------------------------|------------------------|-----------|-------------|-------|
| $V_{DS}$                          | Drain to Source \ | Voltage                 |                        |           | 150         | V     |
| $V_{GS}$                          | Gate to Source V  | /oltage                 |                        |           | ±20         | V     |
|                                   | Drain Current     | -Continuous             | T <sub>C</sub> = 25 °C | (Note 5)  | 25          |       |
| I <sub>D</sub>                    |                   | -Continuous             | T <sub>C</sub> = 100°C | (Note 5)  | 16          | Α     |
|                                   |                   | -Continuous             | T <sub>A</sub> = 25 °C | (Note 1a) | 5.4         | A     |
|                                   |                   | -Pulsed                 |                        | (Note 4)  | 135         |       |
| E <sub>AS</sub>                   | Single Pulse Ava  | lanche Energy           |                        | (Note 3)  | 121         | mJ    |
| Б                                 | Power Dissipatio  | n                       | T <sub>C</sub> = 25 °C |           | 54          | W     |
| $P_{D}$                           | Power Dissipatio  | n                       | T <sub>A</sub> = 25 °C | (Note 1a) | 2.3         | VV    |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and St  | orage Junction Temperat | ure Range              |           | -55 to +150 | °C    |

# **Thermal Characteristics**

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case    | (Note 1)  | 2.3 | °C/W |
|-----------------|---|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 53  | C/VV |

# **Package Marking and Ordering Information**

| Device Marking | Device    | Package | Reel Size | Tape Width | Quantity   |
|----------------|-----------|---------|-----------|------------|------------|
| FDMC86260      | FDMC86260 | Power33 | 13 "      | 12 mm      | 3000 units |

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted.

| Symbol                               | Parameter                                 | Test Conditions                                   | Min. | Тур. | Max. | Units |
|--------------------------------------|---|---|------|------|------|-------|
| Off Chara                            | cteristics                                |   |      |      |      |       |
| BV <sub>DSS</sub>                    | Drain to Source Breakdown Voltage         | $I_D = 250 \mu A, V_{GS} = 0 V$                   | 150  |      |      | V     |
| $\Delta BV_{DSS} \over \Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = 250 $\mu$ A, referenced to 25 °C          |      | 110  |      | mV/°C |
| I <sub>DSS</sub>                     | Zero Gate Voltage Drain Current           | V <sub>DS</sub> = 120 V, V <sub>GS</sub> = 0 V    |      |      | 1    | μΑ    |
| I <sub>GSS</sub>                     | Gate to Source Leakage Current            | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ |      |      | ±100 | nA    |

# On Characteristics

| V <sub>GS(th)</sub>                    | Gate to Source Threshold Voltage                            | $V_{GS} = V_{DS}, I_D = 250 \mu A$                                       | 2 | 2.7 | 4  | V     |
|--|---|--|---|-----|----|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage<br>Temperature Coefficient | $I_D = 250 \mu A$ , referenced to 25 °C                                  |   | -9  |    | mV/°C |
|  |   | $V_{GS} = 10 \text{ V}, I_D = 5.4 \text{ A}$                             |   | 27  | 34 |       |
| r <sub>DS(on)</sub>                    | Static Drain to Source On Resistance                        | $V_{GS} = 6 \text{ V}, I_D = 4.8 \text{ A}$                              |   | 31  | 44 | mΩ    |
| , ,                                    |   | $V_{GS} = 10 \text{ V}, I_D = 5.4 \text{ A}, T_J = 125 ^{\circ}\text{C}$ |   | 55  | 69 |       |
| g <sub>FS</sub>                        | Forward Transconductance                                    | $V_{DD} = 10 \text{ V}, I_D = 5.4 \text{ A}$                             |   | 19  |    | S     |

# **Dynamic Characteristics**

| C <sub>iss</sub> | Input Capacitance            | V 75.V.V 0.V   |     | 1000 | 1330 | pF |
|------------------|------------------------------|--|-----|------|------|----|
| Coss             | Output Capacitance           | $V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V},$<br>f = 1  MHz |     | 105  | 140  | pF |
| C <sub>rss</sub> | Reverse Transfer Capacitance | 1 - 1 1/11/12  |     | 4.8  | 10   | pF |
| $R_{q}$          | Gate Resistance              |  | 0.1 | 0.6  | 1.8  | Ω  |

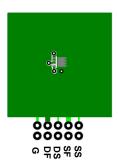
# **Switching Characteristics**

| t <sub>d(on)</sub>  | Turn-On Delay Time            |  |                         | 9.5 | 19 | ns |
|---------------------|-------------------------------|--|-------------------------|-----|----|----|
| t <sub>r</sub>      | Rise Time                     | V <sub>DD</sub> = 75 V, I <sub>D</sub> = 5.4 | 4 A,                    | 2   | 10 | ns |
| t <sub>d(off)</sub> | Turn-Off Delay Time           | V <sub>GS</sub> = 10 V, R <sub>GEN</sub> =   | = 6 Ω                   | 17  | 30 | ns |
| t <sub>f</sub>      | Fall Time                     |  |                         | 3.3 | 10 | ns |
| $Q_{g(TOT)}$        | Total Gate Charge             | $V_{GS} = 0 \text{ V to } 10 \text{ V}$      |                         | 15  | 21 | nC |
| $Q_{g(TOT)}$        | Total Gate Charge             | $V_{GS} = 0 V to 6 V$                        | V <sub>DD</sub> = 75 V, | 9.7 | 14 | nC |
| $Q_{gs}$            | Total Gate Charge             |  | $I_D = 5.4 \text{ A}$   | 4.0 |    | nC |
| $Q_{gd}$            | Gate to Drain "Miller" Charge |  |                         | 3.1 |    | nC |

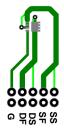
# **Drain-Source Diode Characteristics**

| V               | V <sub>SD</sub> Source to Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 5.4 \text{ A}$ (Note 2) |  | 0.77 | 1.3  | V   |    |
|-----------------|---|--|--|------|------|-----|----|
| VSC             | )   | Source to Drain Diode 1 of ward voltage              | $V_{GS} = 0 \text{ V}, I_S = 1.9 \text{ A}$ (Note 2) |      | 0.72 | 1.2 | V  |
| t <sub>rr</sub> |   | Reverse Recovery Time                                | I <sub>E</sub> = 5.4 A, di/dt = 100 A/μs             |      | 64   | 102 | ns |
| $Q_{rr}$        |   | Reverse Recovery Charge                              | I <sub>F</sub> = 5.4 A, α/αι = 100 Α/μS              |      | 85   | 137 | nC |

<sup>1.</sup> R<sub>0,JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0,JC</sub> is guaranteed by design while R<sub>0,CA</sub> is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%. 3. E<sub>AS</sub> of 121 mJ is based on starting T<sub>J</sub> = 25 °C, L = 3 mH, I<sub>AS</sub> = 9 A, V<sub>DD</sub> = 150 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.1 mH, I<sub>AS</sub> = 22 A. 4. Pulsed Id please refer to Fig 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

# **Typical Characteristics** $T_J = 25$ °C unless otherwise noted.

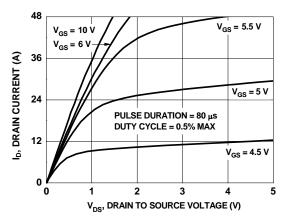


Figure 1. On-Region Characteristics

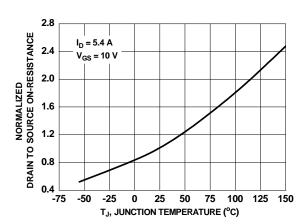


Figure 3. Normalized On-Resistance vs. Junction Temperature

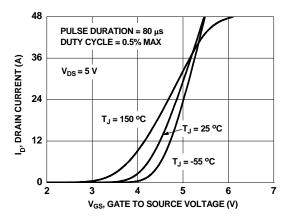


Figure 5. Transfer Characteristics

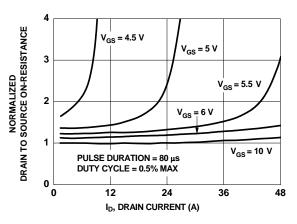


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

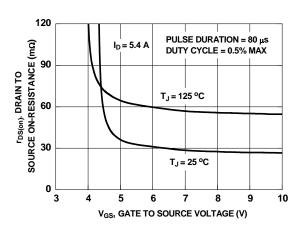


Figure 4. On-Resistance vs. Gate to Source Voltage

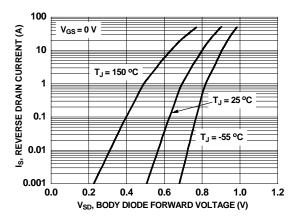


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

# Typical Characteristics $T_J = 25 \, ^{\circ}\text{C}$ unless otherwise noted.

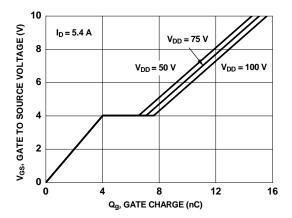


Figure 7. Gate Charge Characteristics

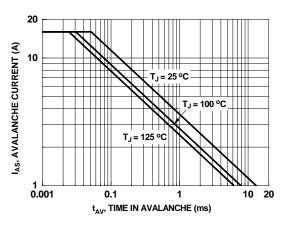


Figure 9. Unclamped Inductive Switching Capability

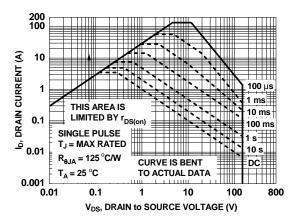


Figure 11. Forward Bias Safe Operating Area

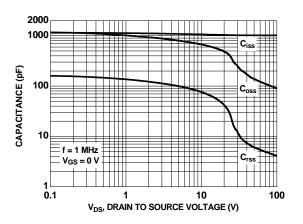


Figure 8. Capacitance vs. Drain to Source Voltage

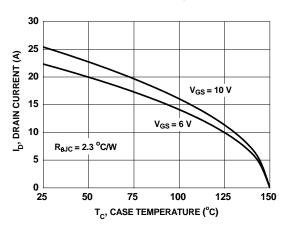


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

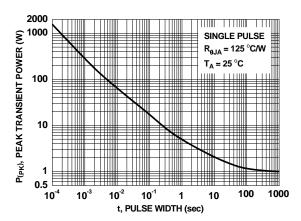


Figure 12. Single Pulse Maximum Power Dissipation

# Typical Characteristics $T_J = 25 \, ^{\circ}\text{C}$ unless otherwise noted.

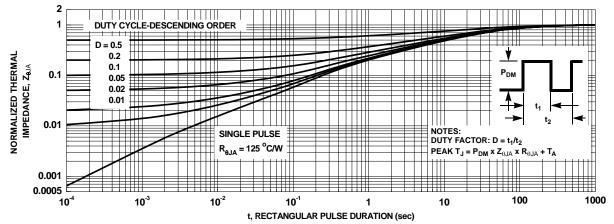
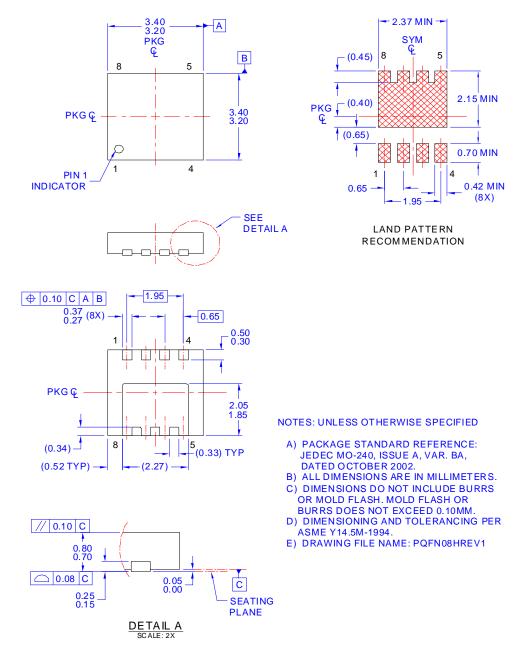


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

# **Dimensional Outline and Pad Layout**



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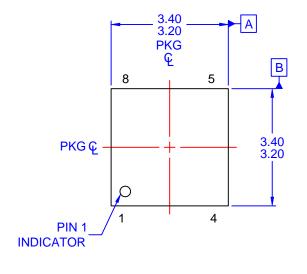
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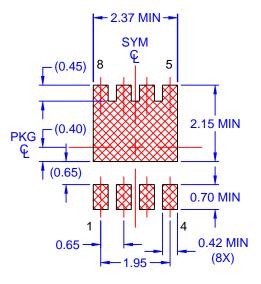
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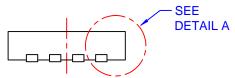
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|--------------------------|-------------------|---|
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| No Identification Needed | Full Production   | Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.   |
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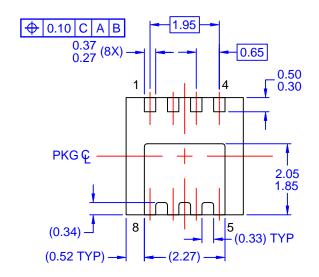
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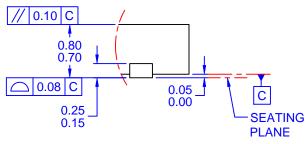


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